

Search Notes**Application/Control No.**

10/568,947

Examiner

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Applicant(s)/Patent under Reexamination

MUTO ET AL.

Art Unit

3747

SEARCHED

Class	Subclass	Date	Examiner
123	399	4/4/2007	HHH
123	345-350	4/4/2007	HHH
123	90.11	4/4/2007	HHH
123	90.15	4/4/2007	HHH
123	90.16	4/4/2007	HHH
123	90.17	4/4/2007	HHH
123	568.11	4/4/2007	HHH
123	568.14	4/4/2007	HHH
73	117.3	4/4/2007	HHH
73	118.2	4/4/2007	HHH
701	106	4/4/2007	HHH
701	110	4/4/2007	HHH
701	115	4/4/2007	HHH
update	search	9/12/2007	HHH

11/14/08 HHH

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
above	search	9/12/2007	HHH
		1/14/2008	HHH

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
East	4/4/2007	HHH
	9/12/2007	HHH
	1/14/2008	HHH